Attorney's Docket No.: 12732-183001 / US6776

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Mitsuaki Osame et al.

Art Unit: 2816

Serial No.: 10/724,365

Examiner: Long T. Nguyen

Filed

: December 1, 2003

Title

: DATA LATCH CIRCUIT AND ELECTRONIC DEVICE

## MAIL STOP AMENDMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This statement is being filed after a first Office Action on the merits, but before receipt of a final Office Action or a Notice of Allowance. The fee in the amount of \$180 in payment for the Information Disclosure Statement is being paid concurrently herewith on the Electronic Filing System (EFS) by way of Deposit Account authorization. Please apply any other charges or credits to Deposit Account No. 06-1050.

Respectfully submitted

Data

Fish & Richardson P.C.

1425 K Street, N.W.

11th Floor

Washington, DC 20005-3500 Telephone: (202) 783-5070 Facsimile: (202) 783-2331

40349743.doc

Roberto J. Devoto

Reg. No. 55,108

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-183001	Application No. 10/724,365	
1	closure Statement oplicant	Applicant Mitsuaki Osame et al.		
(Use several sheets if necessary) (37 CFR §1.98(b))		Filing Date December 1, 2003	Group Art Unit 2816	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	2001/0035862	11/01/2001	Nakamura et al.			04/27/2001
	AB	6,980,191	12/27/2005	Nakamura et al.			04/27/2001
	AC				,		
•	AD	,					
,	AE						
,	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or		-	Trans	lation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL	EP 1150274	10/31/2001	EUROPE			X	
	AM	JP 01-319322	12-25-1989	JAPAN			ABS	•
	AN							
	AO						,	,
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)				
Examiner	Desig.			
Initial	ID	Document		
	AQ			
	AR			
	AS			
	AT			

Examiner Signature	Date Considered				
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.					